CRMLTU3400B

N-Channel 35V, 24mΩ Typ. Power MOSFET

Description

Features

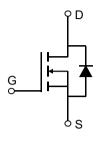
• 35V, 5.5A

$$R_{DS(ON)}$$
 Typ = 24m Ω @ V_{GS} = 10V

 $R_{DS(ON)}$ Typ = $26m\Omega$ @ V_{GS} = 4.5V

 $R_{DS(ON)}$ Typ = $36m\Omega$ @ V_{GS} = 2.5V

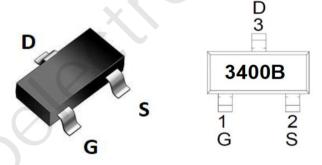
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free





Application

- Load Switch
- PWM Application
- Power Management



Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMLTU3400B	3400B	SOT-23	TAPING	7"	3000	120000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		35	V
V_{GS}	Gate-to-Source Voltage		±12	V
	Continuous Drain Current	T _A = 25°C	5.5	Α
l _D	—Continuous Dialii Current	T _A = 100°C	3.3	Α
I _{DM}	Pulsed Drain Current (1)		22	Α
P_{D}	Power Dissipation	T _A = 25°C	1.56	W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient ⁽²⁾)	80	°C/W
T_J,T_STG	Junction & Storage Temperature Range		-55 to 150	°C

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Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Uni
Off Char	acteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	35	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 35V, V_{GS} = 0V$	-	-	1.0	μΑ
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 12V$	-	-	±100	nA
On Char	acteristics				6	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.5	0.9	1.3	V
		$V_{GS} = 10V, I_D = 2.5A$	-	24	31	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance ⁽³⁾	$V_{GS} = 4.5V, I_D = 2A$	-	26	34	mΩ
		V _{GS} = 2.5V, I _D = 1.5A	- /	36	47	mΩ
Dynamic	Characteristics		5			
C _{iss}	Input Capacitance		X - \	739	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 15V$, f = 1MHz	- <u>-</u>	47	-	pF
C_{rss}	Reverse Transfer Capacitance	I - IIVINZ	U .	39	-	pF
Q_g	Total Gate Charge		-	16	-	nC
Q_gs	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 15V, I_{D} = 3A$	-	1.8	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} - 15V, I _D - 3A	-	1.6	-	nC
Switchin	g Characteristics	.()				
t _{d(on)}	Turn-On DelayTime	-	-	6	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 15V$	-	15	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	$I_D = 3A$, $R_{GEN} = 3\Omega$	-	30	-	ns
t_{f}	Turn-Off Fall Time		-	3.5	-	ns
Drain-So	urce Diode Characteristics and N	lax Ratings				
Is	Maximum Continuous Drain to Source Did	ode Forward Current	-	-	5.5	Α
I _{SM}	Maximum Pulsed Drain to Source Diode I	orward Current	-	-	22	А
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _S = 2A	-	-	1.2	V
trr	Body Diode Reverse Recovery Time		-	9	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 3A$, di/dt = 100A/us	_	3.6	_	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} $R_{\text{\tiny BJA}}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB

^{3.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.

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Test Circuit

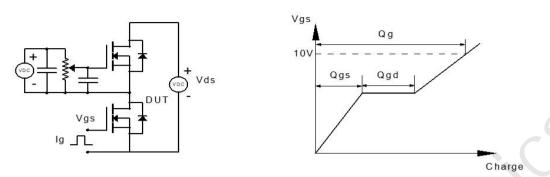


Figure 1: Gate Charge Test Circuit & Waveform

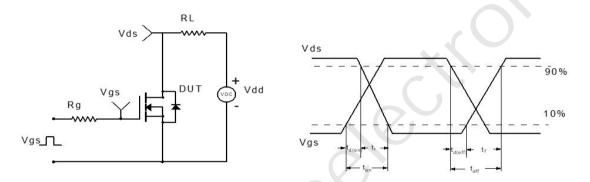


Figure 2: Resistive Switching Test Circuit & Waveform

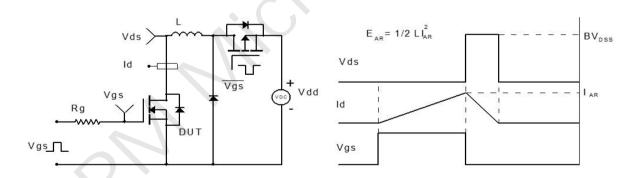


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

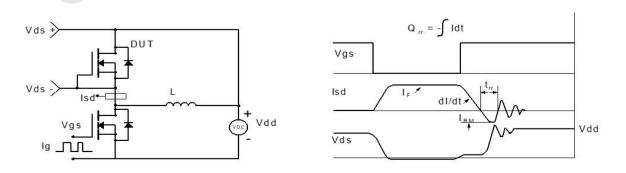
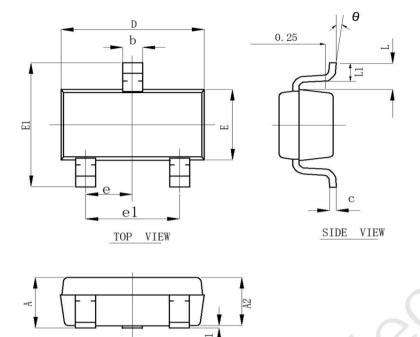


Figure 4: Diode Recovery Test Circuit & Waveform

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Package Mechanical Data(SOT-23)



SIDE VIEW

SYMBOL	MIN	MAX	
A	0.900	1. 150	
A1	0.000	0. 100	
A2	0.900	1.050	
b	0. 300	0. 500	
С	0.080	0. 150	
D	2. 800	3. 000	
Е	1. 200	1.400	
E1	2. 250	2.550	
L	0. 550 REF.		
θ	0°	8°	
L1	0. 300	0.500	
e	0. 950 TYP.		
e ₁	1.800	2.000	

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